

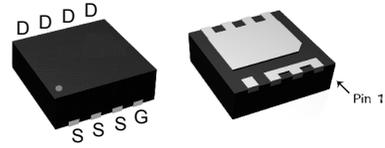
Features

- 30V/54A,
 $R_{DS(ON)} = 5.5m\Omega(max.) @ V_{GS} = 10V$
 $R_{DS(ON)} = 7.5m\Omega(max.) @ V_{GS} = 4.5V$
- Avalanche Rated
- 100% UIS + R_g Tested
- Reliable and Rugged
- Lead Free and Green Devices Available
 (RoHS Compliant)

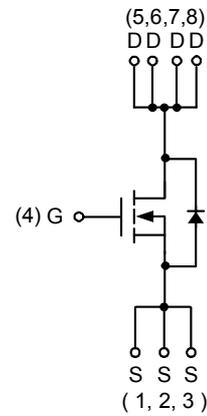
Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

Pin Description



DFN3x3D-8_EP



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
XPX7534RX	DFN3*3-8	7534	5000

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Rating	Unit	
V_{DS}	Drain-Source Voltage	30	V	
V_{GS}	Gate-Source Voltage	± 20		
I_D^a	Continuous Drain Current ($V_{GS}=10\text{V}$)	$T_A=25^\circ\text{C}$	12	A
		$T_A=70^\circ\text{C}$	9.5	
I_{DM}^a	Pulsed Drain Current ($V_{GS}=10\text{V}$)	$T_A=25^\circ\text{C}$	40	
I_D^d	Continuous Drain Current ($V_{GS}=10\text{V}$)	$T_C=25^\circ\text{C}$	54	
		$T_C=70^\circ\text{C}$	42	
I_{DM}	Pulsed Drain Current ($V_{GS}=10\text{V}$)	$T_C=25^\circ\text{C}$	110	
I_S	Diode Continuous Forward Current	40		
I_{AS}^b	Avalanche Current, Single pulse	$L=0.1\text{mH}$	25	
E_{AS}^b	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	31.25	mJ
T_J	Maximum Junction Temperature	150	$^\circ\text{C}$	
T_{STG}	Storage Temperature Range	-55 to 150		
P_D^a	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1.6	W
		$T_A=70^\circ\text{C}$	1	
P_D^d	Maximum Power Dissipation	$T_C=25^\circ\text{C}$	29	W
		$T_C=70^\circ\text{C}$	19	
$R_{\theta JA}^{a,c}$	Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	35	$^\circ\text{C/W}$
		Steady State	60	
$R_{\theta JC}^d$	Thermal Resistance-Junction to Case	Steady State	3.5	

Note a : Surface Mounted on 1in^2 pad area, $t \leq 10\text{sec}$.

Note b : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature $T_J=25^\circ\text{C}$).

Note c : Maximum under Steady State conditions is 75°C/W .

Note d : The power dissipation P_D is based on $T_{J(\text{MAX})} = 150^\circ\text{C}$, and it is useful for reducing junction-to-case thermal resistance ($R_{\theta JC}$) when additional heat sink is used.

Electrical Characteristics (T_A = 25°C Unless Otherwise Noted)

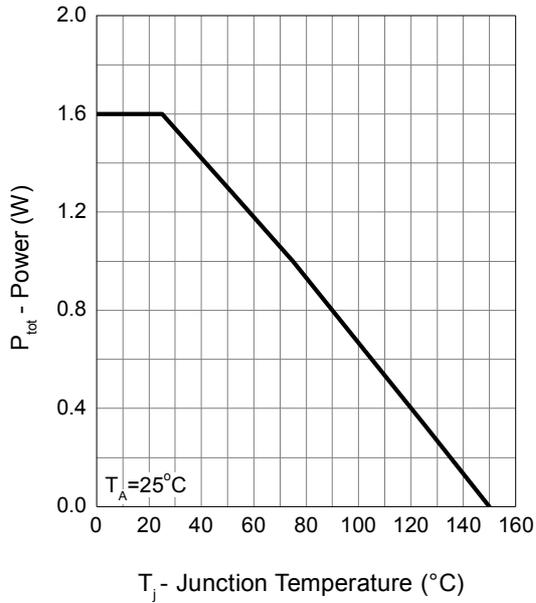
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250μA	30	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V	-	-	1	μA
		T _J =85°C	-	-	30	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250μA	1.5	1.8	2.5	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^a	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =12A	-	4.0	5.5	mΩ
		V _{GS} =4.5V, I _{DS} =9A	-	6.1	7.5	
Diode Characteristics						
V _{SD} ^a	Diode Forward Voltage	I _{SD} =2A, V _{GS} =0V	-	0.8	1.1	V
t _{rr} ^b	Reverse Recovery Time	I _{SD} =12A, dI _{SD} /dt=100A/μs	-	10	-	ns
t _a	Charge Time		-	7	-	
t _b	Discharge Time		-	2.7	-	
Q _{rr} ^b	Reverse Recovery Charge		-	3	-	
Dynamic Characteristics^b						
R _G	Gate Resistance	V _{GS} =0V, V _{DS} =0V, F=1MHz	-	3	4.5	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =15V, Frequency=1.0MHz	560	1155	1540	pF
C _{oss}	Output Capacitance		185	245	345	
C _{rss}	Reverse Transfer Capacitance		99	105	231	
t _{d(ON)}	Turn-on Delay Time	V _{DD} =15V, R _L =15Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω	-	14	26	ns
t _r	Turn-on Rise Time		-	10	19	
t _{d(OFF)}	Turn-off Delay Time		-	44	80	
t _f	Turn-off Fall Time		-	12	23	
Gate Charge Characteristics^b						
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =10V, I _{DS} =12A	-	28.3	39.6	nC
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =4.5V, I _{DS} =12A	-	12.9	18	
Q _{gth}	Threshold Gate Charge		-	2.46	3.44	
Q _{gs}	Gate-Source Charge		-	4.22	5.9	
Q _{gd}	Gate-Drain Charge		-	7.3	10.2	

Note a : Pulse test ; pulse width ≤ 300 μs, duty cycle ≤ 2%.

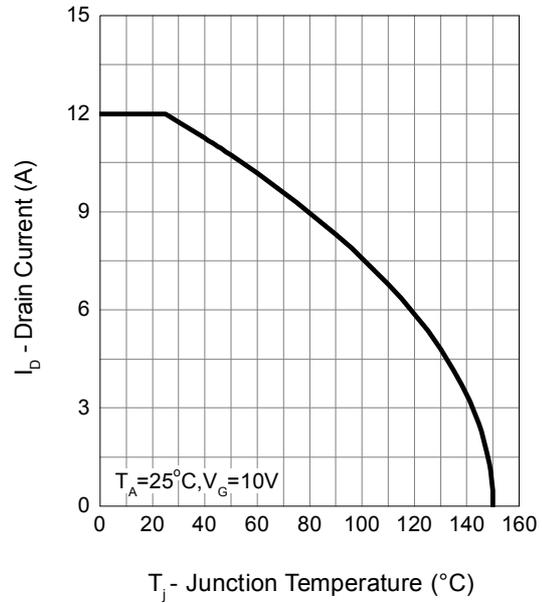
Note b : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

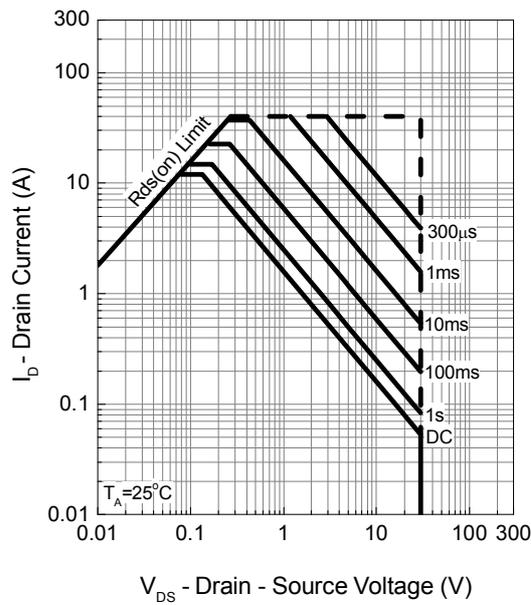
Power Dissipation



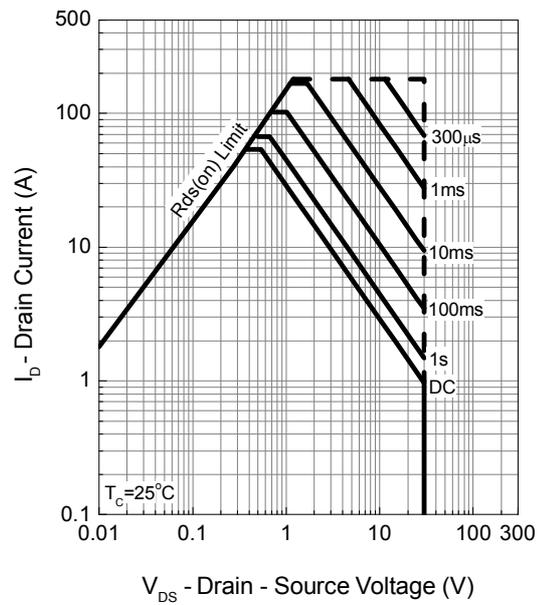
Drain Current



Safe Operation Area

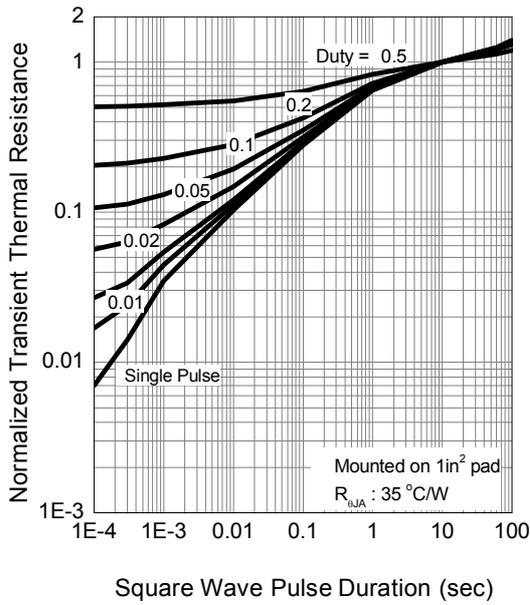


Safe Operation Area

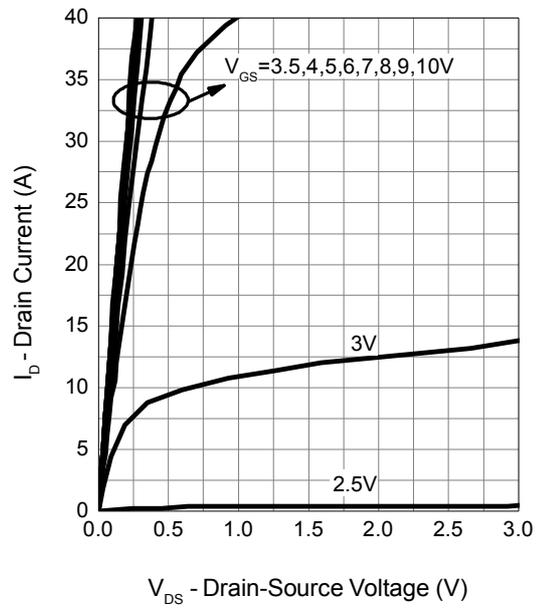


Typical Operating Characteristics (Cont.)

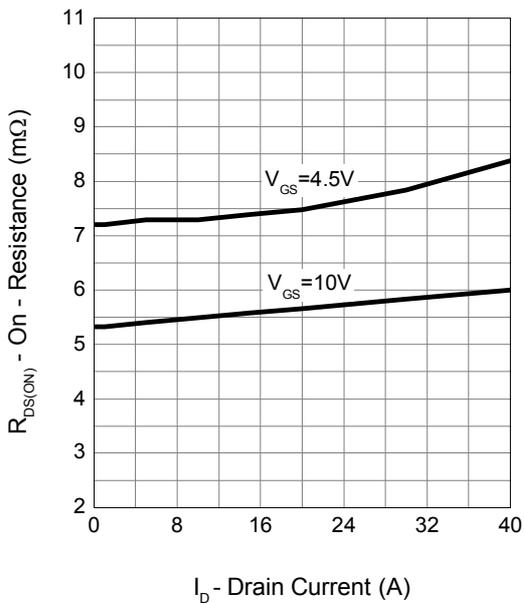
Thermal Transient Impedance



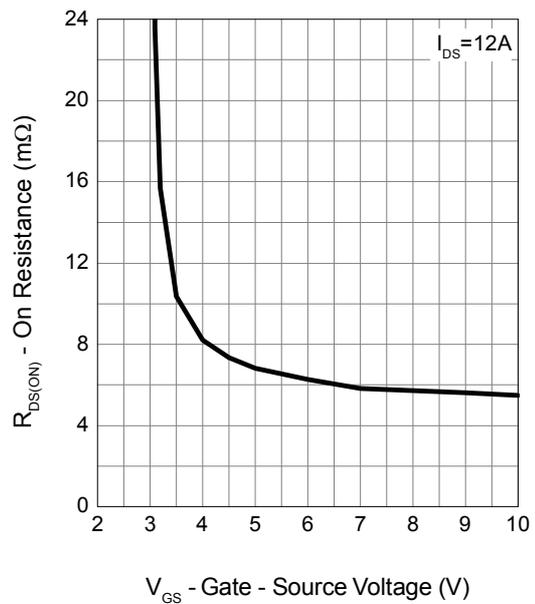
Output Characteristics



Drain-Source On Resistance

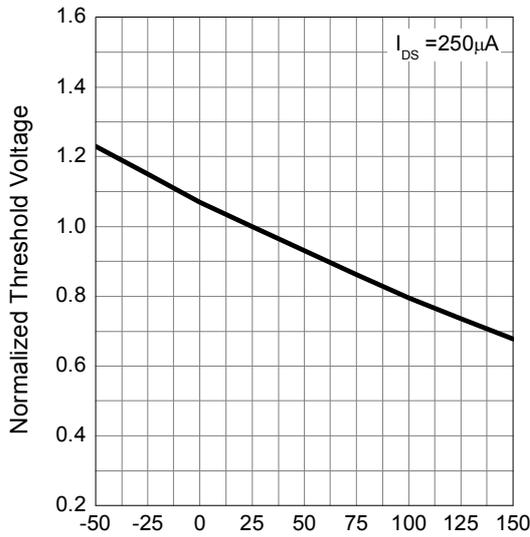


Gate-Source On Resistance



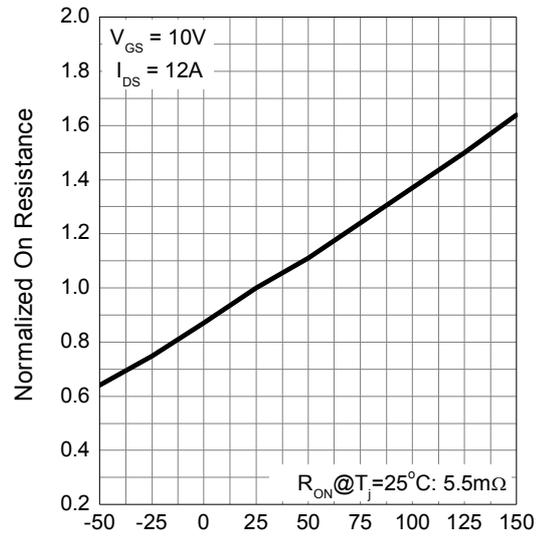
Typical Operating Characteristics (Cont.)

Gate Threshold Voltage



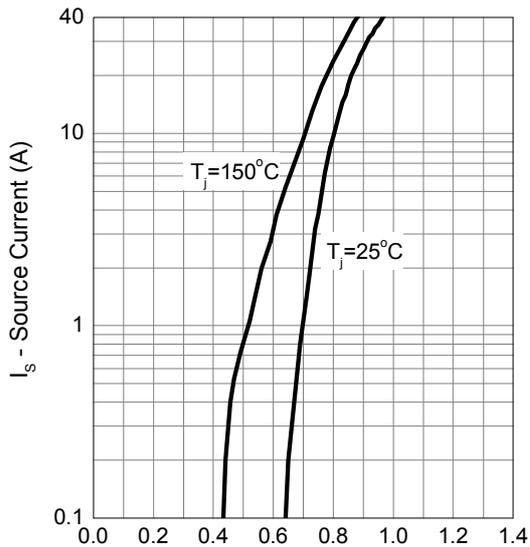
T_j - Junction Temperature ($^{\circ}C$)

Drain-Source On Resistance



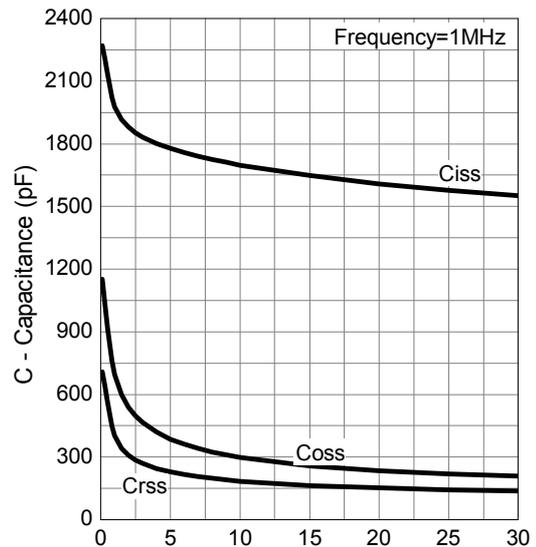
T_j - Junction Temperature ($^{\circ}C$)

Source-Drain Diode Forward



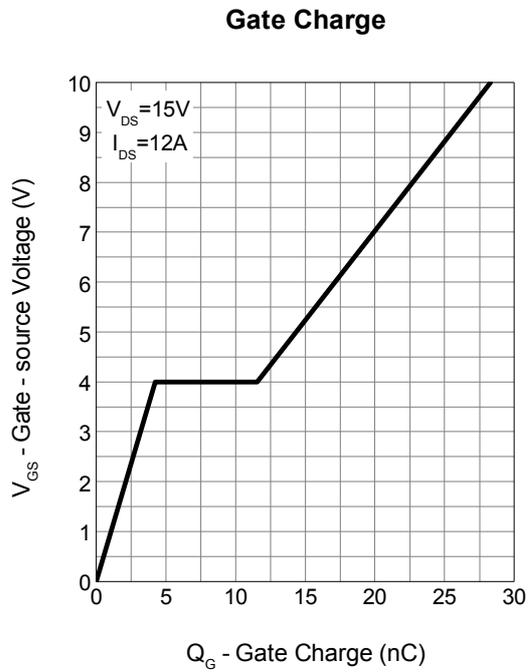
V_{SD} - Source - Drain Voltage (V)

Capacitance

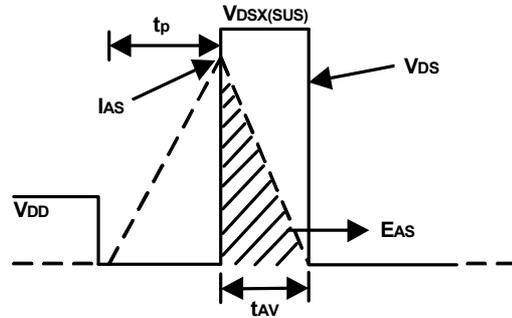
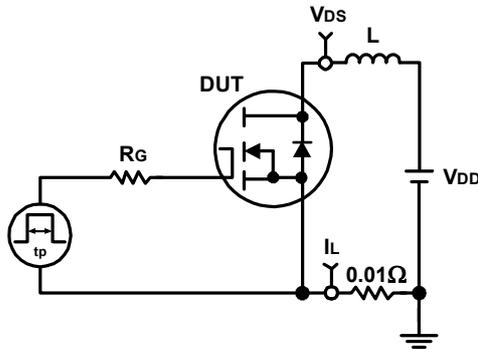


V_{DS} - Drain - Source Voltage (V)

Typical Operating Characteristics (Cont.)



Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms

